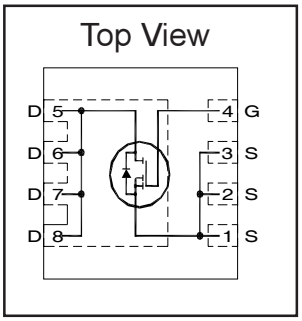
V_{DS}	30	V
$V_{GS\ max}$	± 20	V
$R_{DS(on)\ max}$ (@V_{GS} = 10V)	9.0	mΩ
(@V_{GS} = 4.5V)	13.5	
$Q_{g\ typ.}$	7.1	nC
I_D (@$T_{c(Bottom)}$ = 25°C)	25⑥	A

HEXFET® Power MOSFET



Applications

- Control MOSFET for high frequency buck converters

Features		Benefits
Low Thermal Resistance to PCB (< 4.5°C/W)		Enable better thermal dissipation
Low Profile (<1.2mm)		Increased Power Density
Industry-Standard Pinout	results in	Multi-Vendor Compatibility
Compatible with Existing Surface Mount Techniques	⇒	Easier Manufacturing
RoHS Compliant, Halogen-Free		Environmentally Friendlier
MSL1, Consumer Qualification		Increased Reliability

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFHM8334PBF	PQFN 3.3mm x 3.3mm	Tape and Reel	4000	IRFHM8334TRPBF

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{GS}	Gate-to-Source Voltage	± 20	V
I_D @ T_A = 25°C	Continuous Drain Current, V_{GS} @ 10V	13	A
I_D @ $T_{C(Bottom)}$ = 25°C	Continuous Drain Current, V_{GS} @ 10V	43⑤⑥	
I_D @ $T_{C(Bottom)}$ = 100°C	Continuous Drain Current, V_{GS} @ 10V	27⑤⑥	
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V (Source Bonding Technology Limited)	25⑥	
I_{DM}	Pulsed Drain Current	176	
P_D @T_A = 25°C	Power Dissipation ④	2.7	W
P_D @$T_{C(Bottom)}$ = 25°C	Power Dissipation	28	
	Linear Derating Factor	0.021	W/°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C

Notes ① through ⑥ are on page 8

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	30	—	—	V	V_{GS} = 0V, I_D = 250µA
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	21	—	mV/°C	Reference to 25°C, I_D = 1.0mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	7.2	9.0	mΩ	V_{GS} = 10V, I_D = 20A ②
		—	11.2	13.5		V_{GS} = 4.5V, I_D = 16A ②
$V_{GS(th)}$	Gate Threshold Voltage	1.35	1.8	2.35	V	V_{DS} = V_{GS}, I_D = 25µA
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient	—	-6.6	—	mV/°C	
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	µA	V_{DS} = 24V, V_{GS} = 0V
		—	—	150		V_{DS} = 24V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V_{GS} = -20V
gfs	Forward Transconductance	44	—	—	S	V_{DS} = 10V, I_D = 20A
Q_g	Total Gate Charge	—	15	—	nC	V_{GS} = 10V, V_{DS} = 15V, I_D = 20A
Q_g	Total Gate Charge	—	7.1	11	nC	V_{DS} = 15V V_{GS} = 4.5V I_D = 20A
Q_{gs1}	Pre-Vth Gate-to-Source Charge	—	2.5	—		
Q_{gs2}	Post-Vth Gate-to-Source Charge	—	1.0	—		
Q_{gd}	Gate-to-Drain Charge	—	2.3	—		
Q_{godr}	Gate Charge Overdrive	—	1.3	—		
Q_{sw}	Switch Charge (Q_{gs2} + Q_{gd})	—	3.3	—		
Q_{oss}	Output Charge	—	5.7	—	nC	V_{DS} = 16V, V_{GS} = 0V
R_G	Gate Resistance	—	1.2	—	Ω	
$t_{d(on)}$	Turn-On Delay Time	—	8.3	—	ns	V_{DD} = 30V, V_{GS} = 4.5V I_D = 20A R_G=1.8Ω
t_r	Rise Time	—	14	—		
$t_{d(off)}$	Turn-Off Delay Time	—	7.0	—		
t_f	Fall Time	—	4.6	—		
C_{iss}	Input Capacitance	—	1180	—	pF	V_{GS} = 0V V_{DS} = 10V f = 1.0MHz
C_{oss}	Output Capacitance	—	260	—		
C_{rss}	Reverse Transfer Capacitance	—	110	—		

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ①		35	mJ

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	25⑥	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode)	—	—	176		
V_{SD}	Diode Forward Voltage	—	—	1.0	V	T_J = 25°C, I_S = 20A, V_{GS} = 0V ②
t_{rr}	Reverse Recovery Time	—	13	20	ns	T_J = 25°C, I_F = 20A, V_{DD} = 15V
Q_{rr}	Reverse Recovery Charge	—	19	29	nC	di/dt = 380 A/µs ②

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$ (Bottom)	Junction-to-Case ③	—	4.5	°C/W
$R_{\theta JC}$ (Top)	Junction-to-Case ③	—	44	
$R_{\theta JA}$	Junction-to-Ambient ④	—	47	
$R_{\theta JA}$ (<10s)	Junction-to-Ambient ④	—	30	

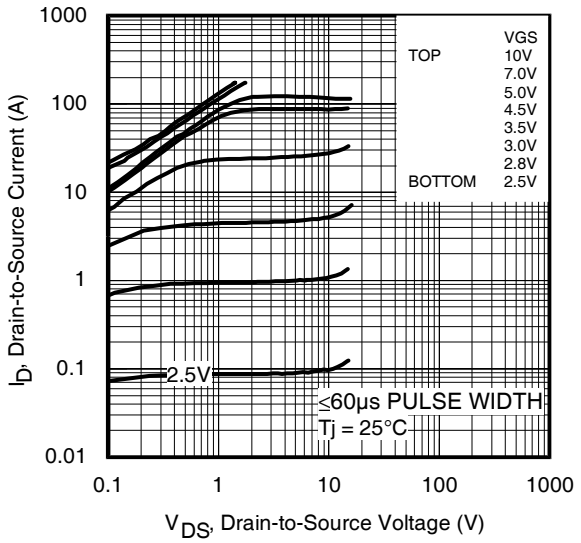


Fig 1. Typical Output Characteristics

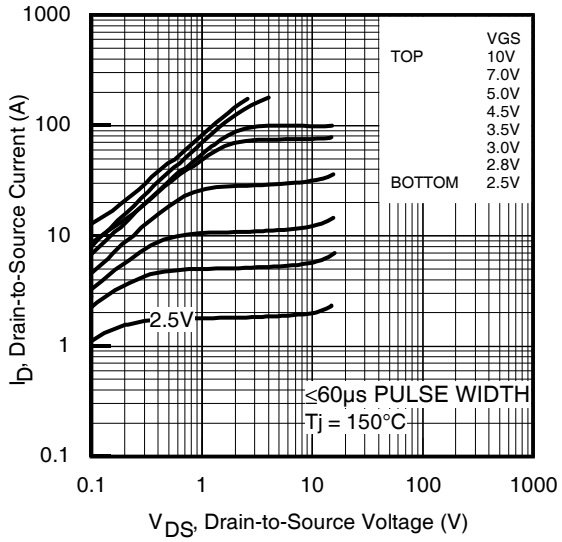


Fig 2. Typical Output Characteristics

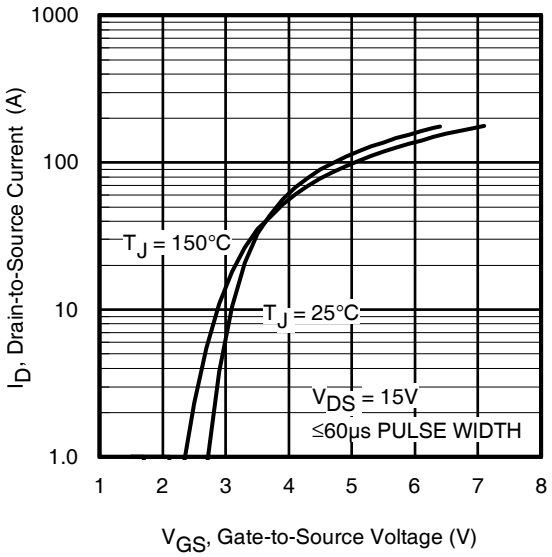


Fig 3. Typical Transfer Characteristics

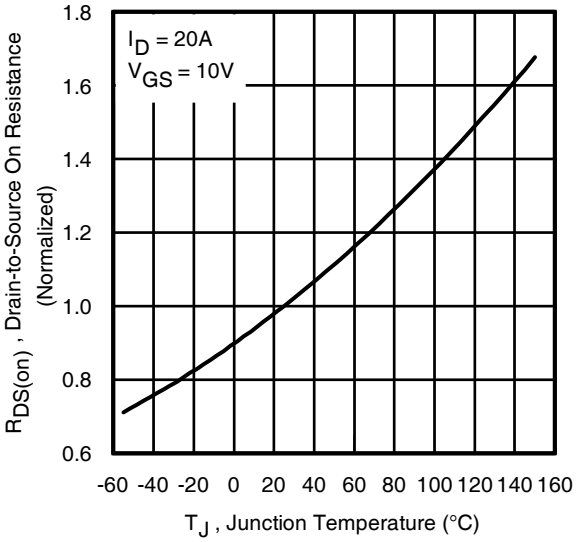


Fig 4. Normalized On-Resistance vs. Temperature

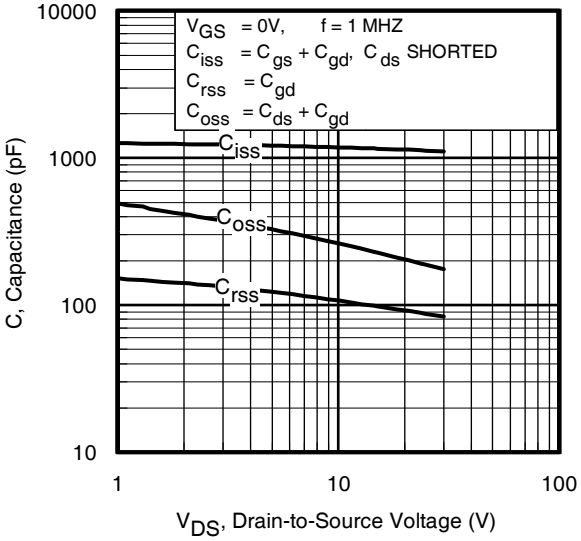


Fig 5. Typical Capacitance vs.Drain-to-Source Voltage

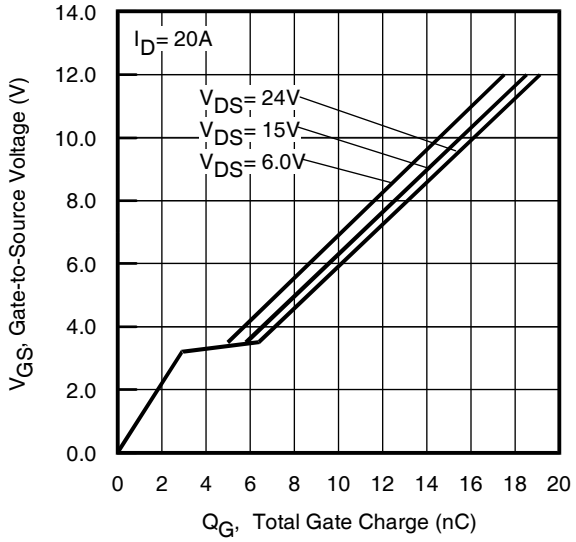


Fig 6. Typical Gate Charge vs.Gate-to-Source Voltage

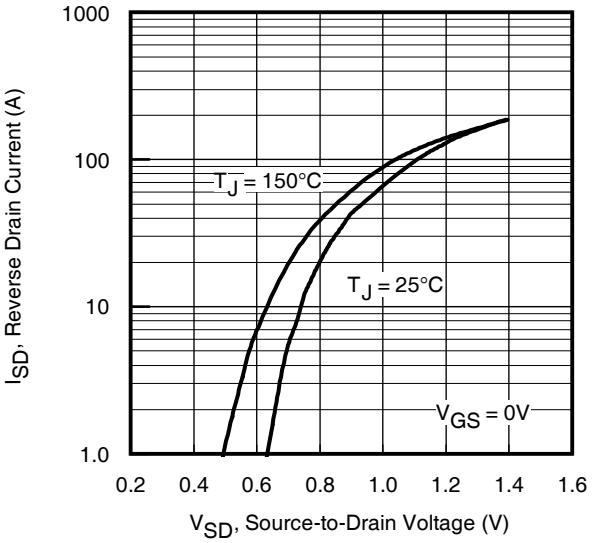


Fig 7. Typical Source-Drain Diode Forward Voltage

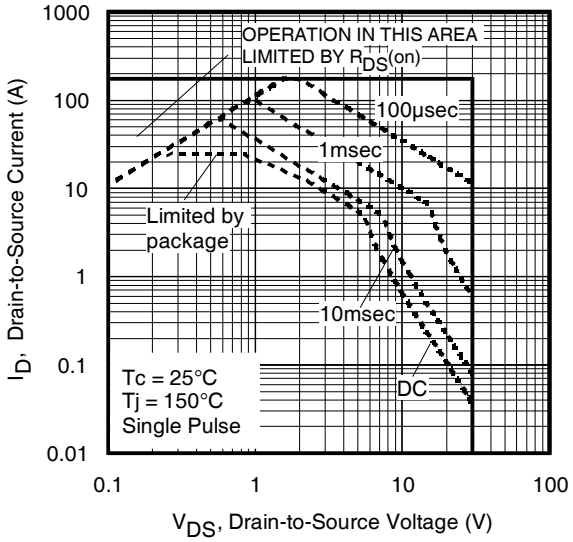


Fig 8. Maximum Safe Operating Area

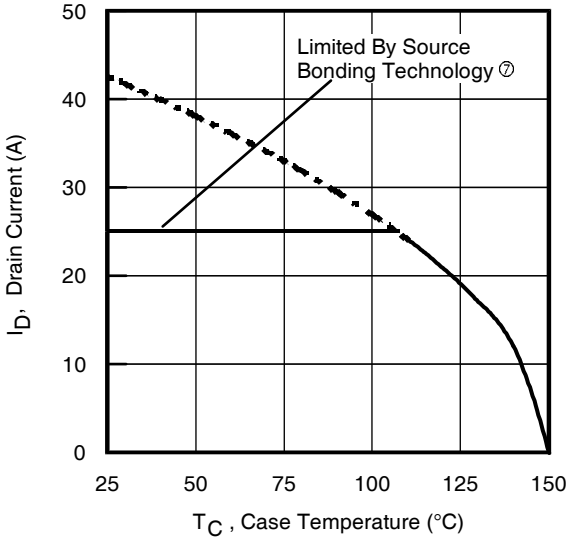


Fig 9. Maximum Drain Current vs. Case (Bottom) Temperature

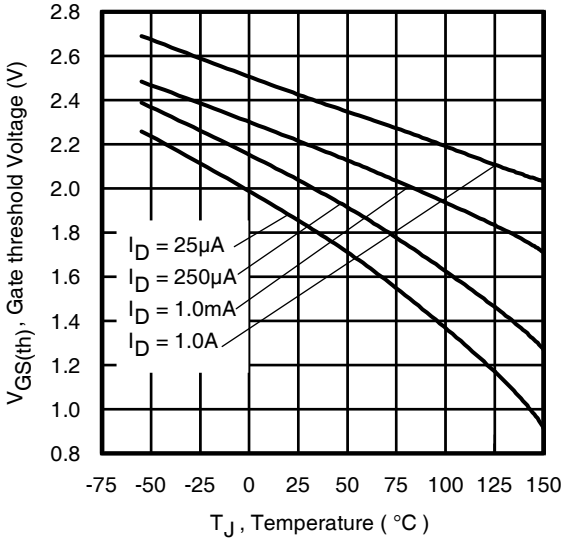


Fig 10. Threshold Voltage vs. Temperature

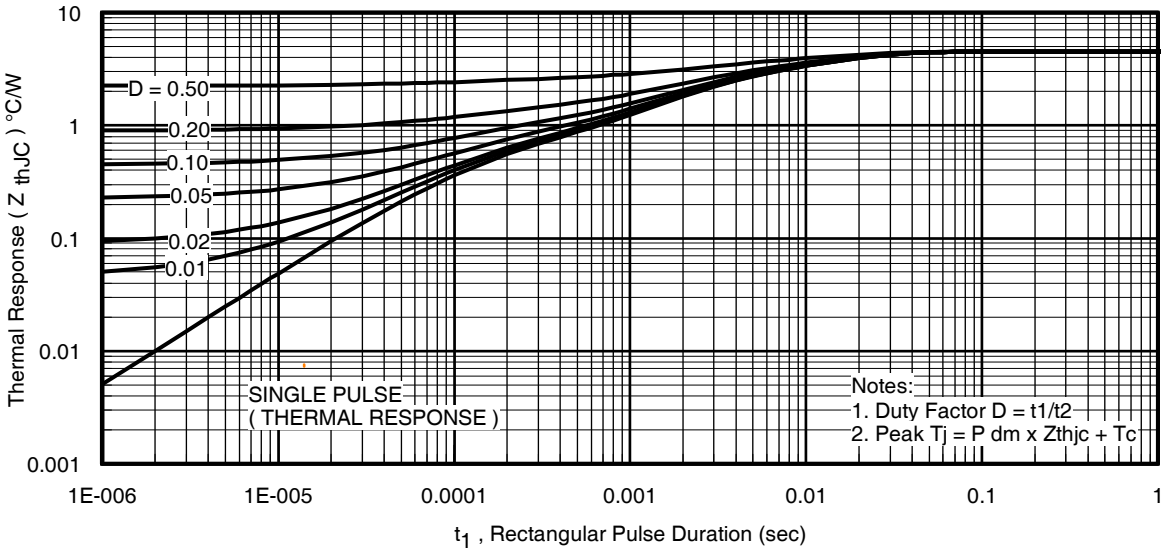


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case (Bottom)

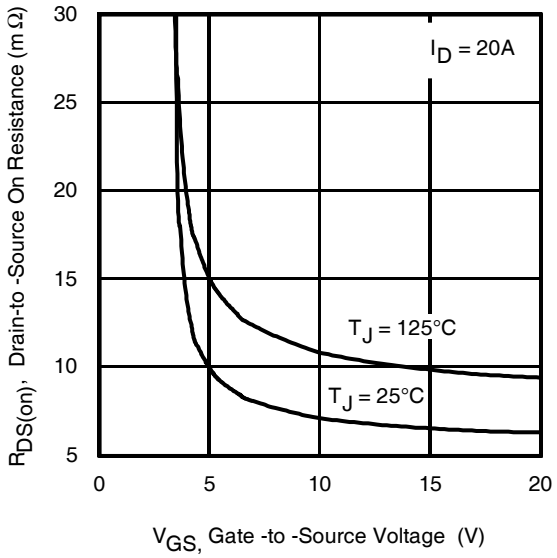


Fig 12. On-Resistance vs. Gate Voltage

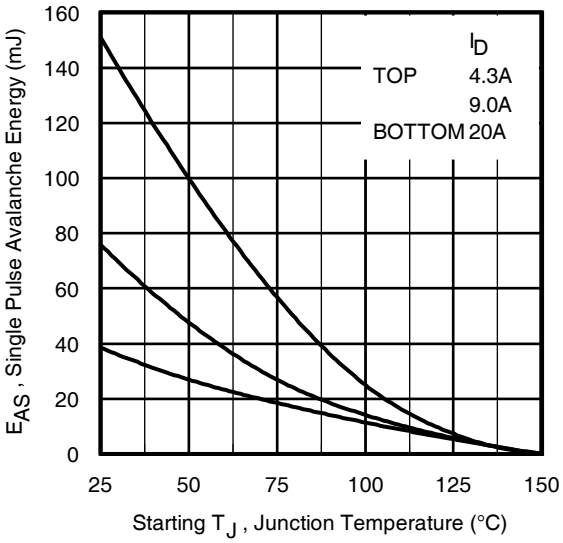


Fig 13. Maximum Avalanche Energy vs. Drain Current

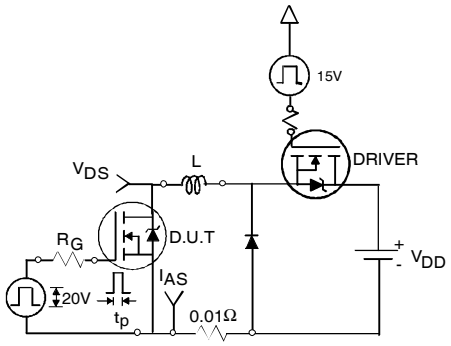


Fig 14a. Unclamped Inductive Test Circuit

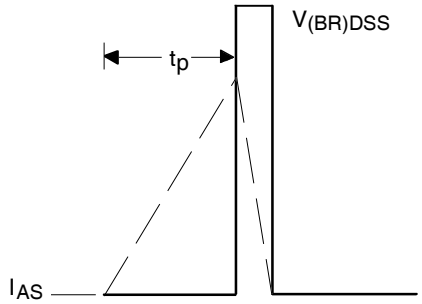


Fig 14b. Unclamped Inductive Waveforms

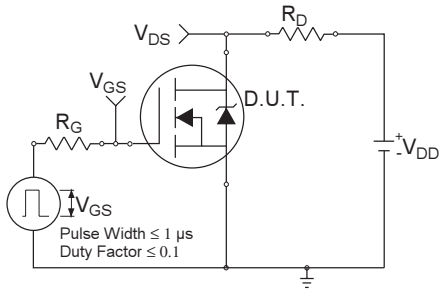


Fig 15a. Switching Time Test Circuit

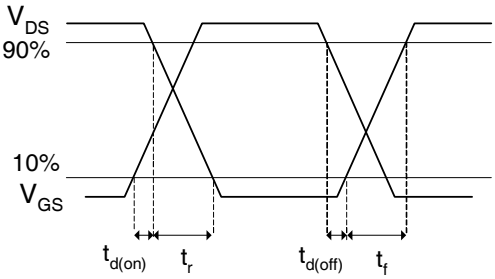


Fig 15b. Switching Time Waveforms

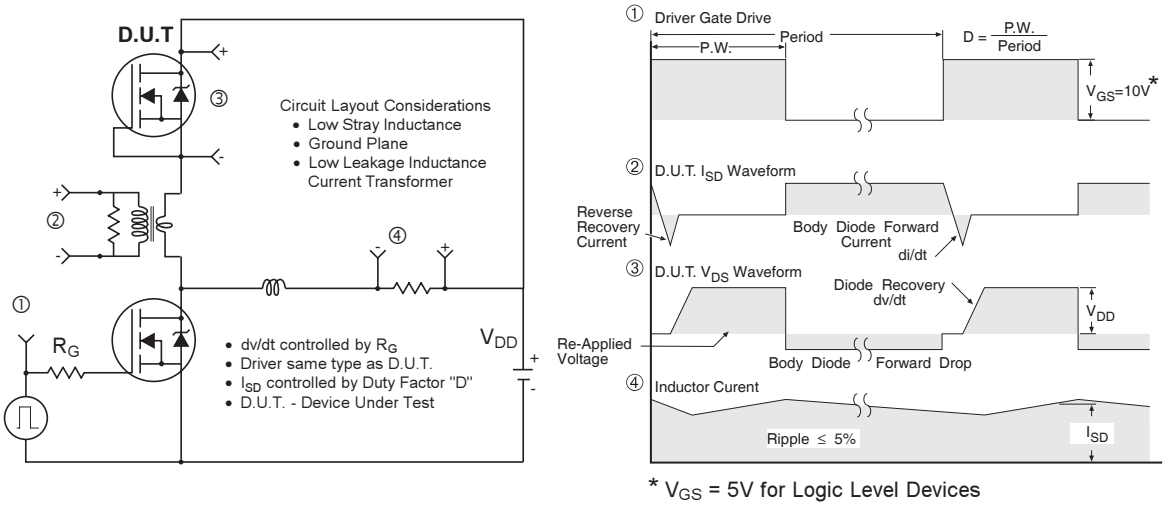


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

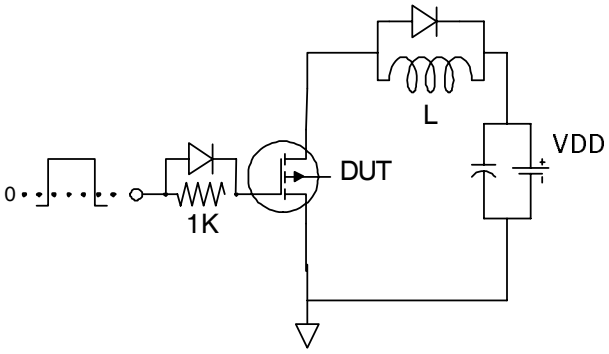


Fig 17. Gate Charge Test Circuit

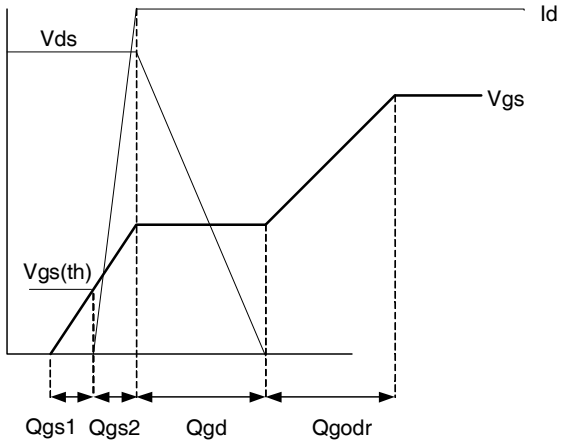
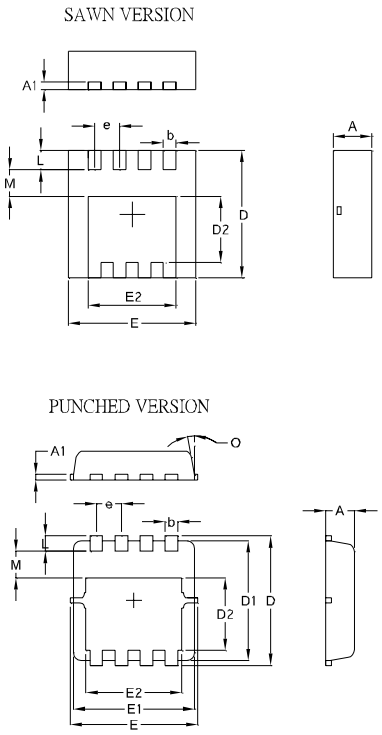


Fig 18. Gate Charge Waveform

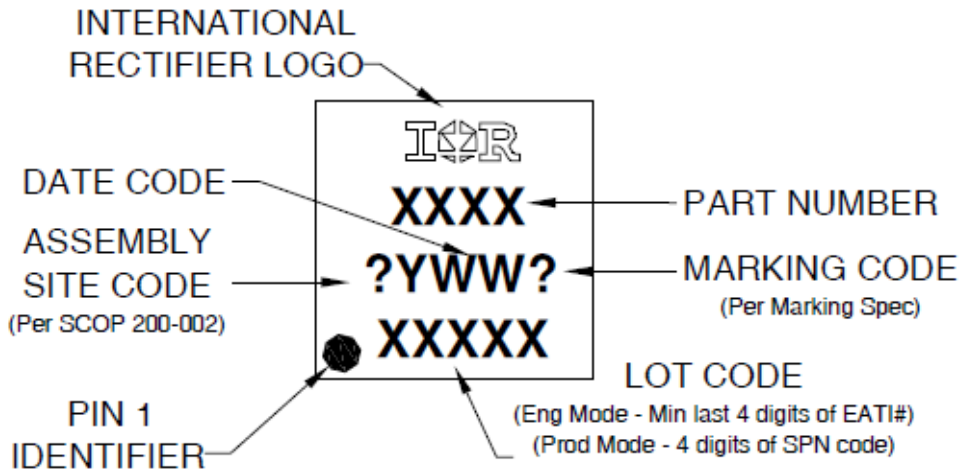
PQFN 3.3mm x 3.3mm Outline Package Details



SYMBOL	COMMON			
	MM		INCH	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.05	0.0276	0.0413
A1	0.12	0.39	0.0047	0.0154
b	0.25	0.39	0.0098	0.0154
D	3.20	3.45	0.1260	0.1358
D1	3.00	3.20	0.1181	0.1417
D2	1.69	2.20	0.0665	0.0866
E	3.20	3.40	0.1260	0.1339
E1	3.00	3.20	0.1181	0.1417
E2	2.15	2.59	0.0846	0.1020
e	0.65 BSC		0.0256 BSC	
L	0.15	0.55	0.0059	0.0217
M	0.59	—	0.0232	—
O	9Deg	12Deg	9Deg	12Deg

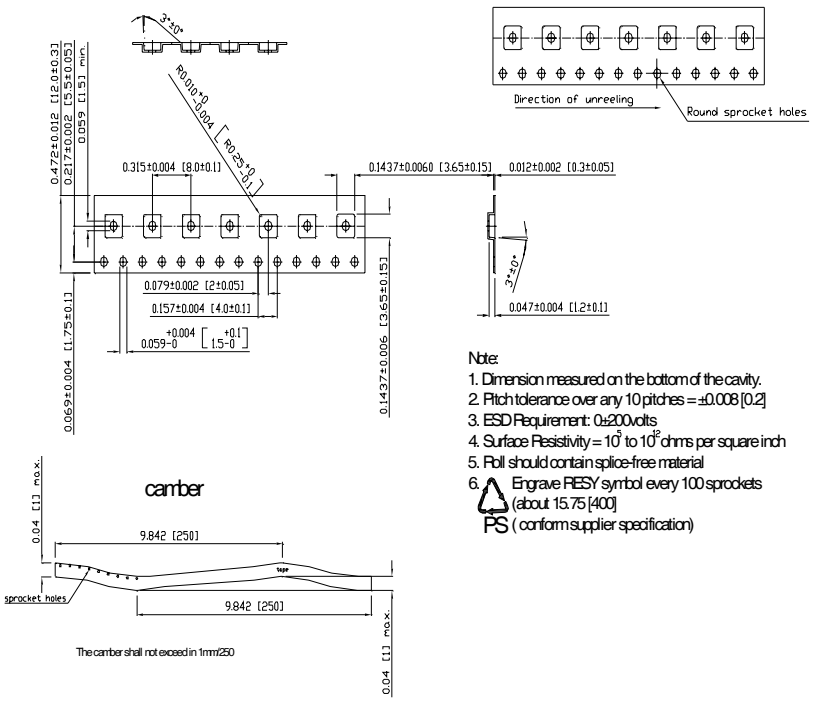
For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf
For more information on package inspection techniques, please refer to application note AN-1154:
http://www.irf.com/technical-info/appnotes/an-1154.pdf

PQFN 3.3mm x 3.3mm Outline Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

PQFN 3.3mm x 3.3mm Outline Tape and Reel



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Qualification information†

Qualification level	Consumer†† (per JEDEC JESD47F††† guidelines)	
Moisture Sensitivity Level	PQFN 3.3mm x 3.3mm	MSL1 (per JEDEC J-STD-020D†††)
RoHS compliant	Yes	

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability

†† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: http://www.irf.com/whoto-call/salesrep/

††† Applicable version of JEDEC standard at the time of product release.

Notes:

① Starting T_J = 25°C, L = 0.18mH, R_G = 50Ω, I_{AS} = 20A.

② Pulse width ≤ 400µs; duty cycle ≤ 2%.

③ R_θ is measured at T_J of approximately 90°C.

④ When mounted on 1 inch square PCB (FR-4). Please refer to AN-994 for more details: http://www.irf.com/technical-info/appnotes/an-994.pdf

⑤ Calculated continuous current based on maximum allowable junction temperature.

⑥ Current is limited to 25A by source bonding technology.

International IOR Rectifier

IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA
To contact International Rectifier, please visit http://www.irf.com/whoto-call/

